

Notice of References Cited	Application/Control No. 10/551,168		Applicant(s)/Patent Under Reexamination CHUNG ET AL.	
	Examiner Mark Kopec		Art Unit 1796	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2009/0085015	04-2009	Sato et al.	252/519.21
*	B	US-2008/0032062	02-2008	Meiere, Scott Houston	427/576
*	C	US-6,965,045	11-2005	Jung et al.	556/113
*	D	US-6,942,825	09-2005	Honda et al.	252/520.3
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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